

INFRARED EMITTING DIODES



LIR3333-PF/TBS-1

DATA SHEET

DOC. NO: QW0905-LIR3333-PF/TBS-1

REV. A

DATE : <u>15 - May. - 2009</u>

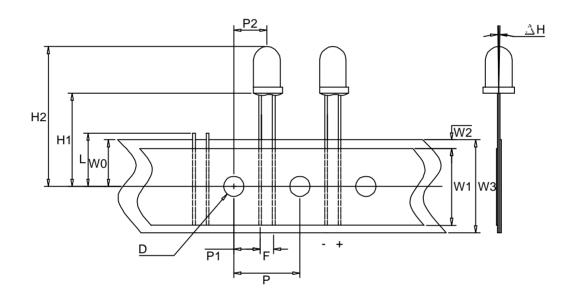




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Package Dimensions





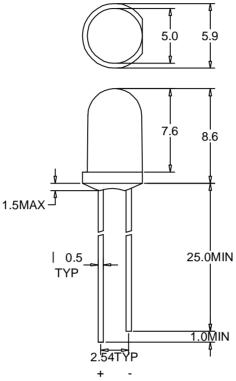
Note : 1.All dimension are in millimeter tolerance is ± 0.25 mm unless otherwise noted.

2. Specifications are subject to change without notice.

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Package Dimensions



NOTE:1.All dimension are in millimeters tolerance is **=**0.25 unless otherwise noted 2.Specifications are subject to change without notice

Features:

- 1. High radiant intensity.
- 2. Suitable for pulsed applications.
- 3. Low average degradation.

Descriptions:

The LIR3333/TBS-1-PF series are high power solution grown efficiency Gallium Arsenide infrared emitting diodes encapsulated in blue transparent plastic T-1 3/4 package individually

Device Selection Guide:

PART NO	MATERIAL	LENS COLOR
LIR3333-PF/TBS-1	AlGaAs/GaAs	Water Clear



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Absolute Maximum Ratings at Ta=25 ℃

Parameter	Symbol	Ratings	UNIT	
Parameter	Gymbol	IR	UNII	
Forward Current	lF	50	mA	
Peak Forward Current (300PPS,10 μ s Pulse)	lfP	1	А	
Power Dissipation	PD	100	mW	
Reverse Voltage	Vr	5	V	
Electrostatic Discharge	ESD	2000	V	
Operating Temperature	Topr	-40 ~ +85	Ű	
Storage Temperature	Tstg	-40 ~ +85	Ü	

Electrical Optical Characteristics (Aa=25°C)

PARAMETER	SYMBOL	Min.	Тур.	Max.	UNIT	TEST CONDITION
Radiant Intensity	Le	6.0	10.0		mW/sr	IF=20mA
Aperture Radiant Incidence	Ee	0.9	1.4		mW/cm ²	IF=20mA
Peak Emission Wavelength	À peak		940		nm	IF=20mA
Spectral Line Half Width	Δλ		50		nm	IF=20mA
Forward Voltage (@ 40 ms)	VF		1.2	1.6	V	IF=20mA
Reverse Current	IR			100	μA	VR=5V
Viewing Angle	2 () 1/2		20		deg	

2. The radiant intensity data did not including \equiv 15% testing tolerance.



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• Dimension Symbol Information

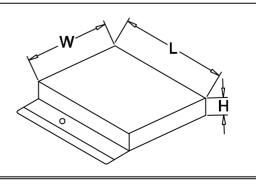
	OPTION CODE	SYMBOL	SPECIFICATIONS			
SYMBOL ITEMS			Minimum		Maximum	
			mm	inch	mm	inch
Tape Feed Hole Diameter		D	3.8	0.15	4.2	0.17
Component Lead Pitch		F	2.3	0.09	3.0	0.12
Front-To-Rear Deflection		.∆H			2.0	0.08
	TBS-1		17.5	0.69	18.5	0.73
Feed Hole To Bottom Of Component		H1				
Feed Hole To Overall Component Height		H2			36	1.42
Lead Length After Component Height		L	Wo		11	0.43
Feed Hole Pitch		Р	12.4	0.49	13	0.51
Lead Location		P1	4.4	0.17	5.8	0.23
Center Of Component Location		P2	5.1	0.2	7.7	0.3
Overall Taped Package Thickness		Т			1.42	0.06
Feed Hole Location		W0	8.5	0.33	9.75	0.38
Adhesive Tape Width		W1	14.5	0.57	15.5	0.61
Adhesive Tape Position		W2	0	0	4.0	0.16
Tape Width		W3	17.5	0.69	19	0.75

REMARK:TBS=Tape And Box Straight Leads

Dimensions Symbol Information

	Symbol	Specification				
Description		minimum		maxmum		
		mm	inch	mm	inch	
Overall Length	L	330	13.0	340	13.4	
Overall Width	W	265	10.4	275	10.8	
Overall Thickness	Н	50	1.97	60	2.4	
Quantity/Box	2000PCS					

Package Dimensions





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Typical Electro-Optical Characteristics Curve

IR CHIP

Fig.1 Forward Current vs. Forward Voltage

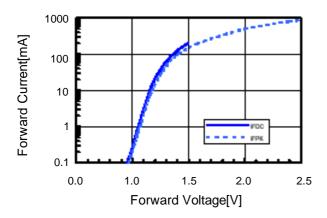


Fig.2 Relative Radiant Power vs. Wavelength

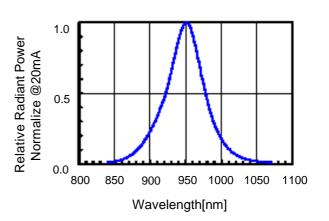


Fig.3 Relative Radiant Power vs. Forward DC Current

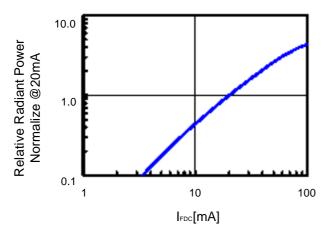


Fig.4 Relative Radiant Power

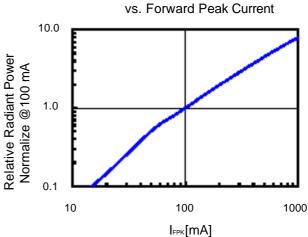


Fig.5 Forward DC Voltage vs. Temperature

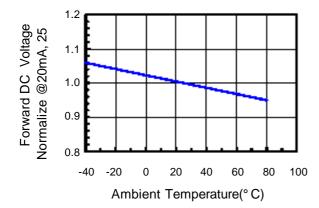
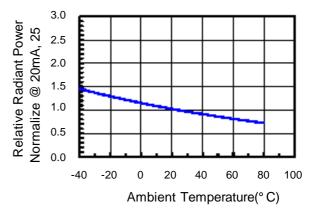


Fig.6 Relative Radiant Power vs. Temperature





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Storage time:

- 1.The operation of Temperatures and RH are : 5 ♥ ~35 ♥ ,RH<60%.
- 2.Once the package is opened, the products should be used within a week. Otherwise, they should be kept in a damp proof box with descanting agent. Considering the tape life, we suggest our customers to use our products within a year(from production date).
- 3.If opened more than one week in an atmosphere 5 ℃ ~ 35 ℃,RH<60%, they should be treated at 60 ℃ _5 ℃ for 15hrs.

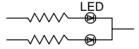
Drive Method:

LED is a current operated device, and therefore, require some kind of current limiting incorporated into the driver circuit. This current limiting typically takes the form of a current limiting resistor placed in series with the LED.

Consider worst case voltage variations than could occur across the current limiting resistor. The forwrd current should not be allowed to change by more than 40 % of its desired value.

Circuit model A

Circuit model B





- (A) Recommended circuit.
- (B) The difference of brightness between LED could be found due to the VF-IF characteristics of LED.

Cleaning:

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LED.

ESD(Electrostatic Discharge):

Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrosatic glove is recommended when handing these LED. All devices, equipment and machinery must be properly grounded.

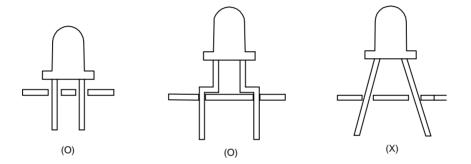


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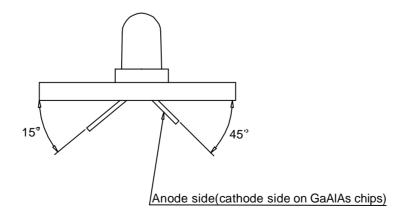
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Mounting:

1. If the leads are subjected to stress during soldering a printed circuit board, illumination failure may result immediately or later during use. For this reason, make sure that the intervals between the installation holes in the board are equal to the intervals between the leads (after forming if done) so that no stress is applied to the lead.



 The LED lamps are designed for high-density mounting and have a structure which can alleviate mechanical stress due to clinching. Nevertheless, take care to avoid the occurrence of residual mechanical stress due to clinching.





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Soldering Condition(Pb-Free)

1.Iron:

Soldering Iron:30W Max
Temperature 350°C Max
Soldering Time:3 Seconds Max(One time only)
Distance:2mm Min(From solder joint to body)

2. Wave Soldering Profile

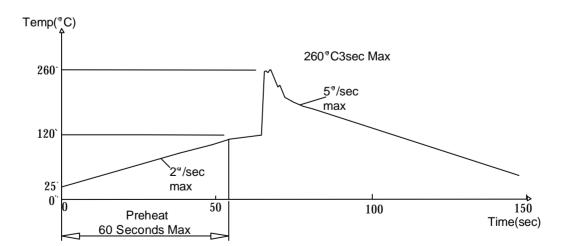
Dip Soldering Preheat: 120°C Max

Preheat time: 60seconds Max

Ramp-up 2°C/sec(max)

Ramp-Down:-5°C/sec(max) Solder Bath:260°C Max Dipping Time:3 seconds Max

Distance:2mm Min(From solder joint to body)



Note: 1. Wave solder should not be made more than one time.

2. You can just only select one of the soldering conditions as above.



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Reliability Test:

Test Item	Test Condition	Description	Reference Standard	
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and themal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1	
High Temperature Storage Test	1.Ta=85 🚡 🗓 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10	
Low Temperature Storage Test	1.Ta=-40 ~ 15 C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12	
High Temperature High Humidity Test	1.Ta=65 ** ±5 +5 2.RH=90 %~95 % 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11	
Thermal Shock Test	1.Ta=105 © 15 (1&-40 © 15 (1 (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011	
Solder Resistance Test	1.T.Sol=260 ℃ ¼5℃ 2.Dwell time= 10 ¼1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1	
Solderability Test	1.T.Sol=230 TL5TC 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2	